Search Notes



٠	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/528,461	KIM ET AL.	
	Examiner	Art Unit	
	Jason M. Nolan, Ph.D.	1626	

	SEARCHED				
Class	Subclass	Date	Examiner		
544	131	11/13/2006	JMN		
514	235.5	11/13/2006	JMN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
544	131	11/12/2006	JMN	
514	235.5	11/12/2006	JMN	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STN Structure Search (Registry, Caplus), printout attached	11/13/2006	JMN	
ABS, Oath, Blb data, Spec, Priority Documents, & IDS reviewed	11/13/2006	JMN	
Inventor Search, reviewed for double patenting	11/13/2006	ИМС	
East Class/Subclass searhed; printout attached	11/28/2006	NML	
Amendments reviewed for new matter	3/15/2007	JMN	